

XA-10186
PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

MIYAKI, Yoshinori et al.

Intl. Appln. No.: PCT/JP03/04394

Intl. Filing Date: 7 April 2003

For: SEMICONDUCTOR DEVICE AND ITS MANUFACTURING METHOD

* * *

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450
Attn: Mail Stop PCT, DO/EO/US

Sir:

Pursuant to 37 C.F.R. § 1.56, and without any assertion as to materiality or prior art effect, the documents listed on the attached Form PTO-1449 are hereby cited.

Documents AA-AD and AH-AQ on the attached List were cited in the International Search Report (copy attached). The Office should have received copies of the primary citations from the PCT International Authority. So copies are not being submitted herewith in order to avoid duplication. If the Office did not receive the copies from the PCT International Authority, the Examiner is requested to telephone the undersigned so that copies may be provided.

Documents AR-AS (copies herewith) are cited in the

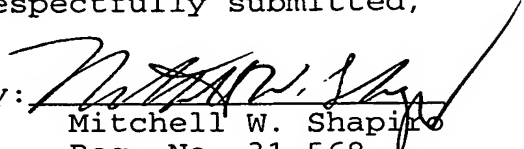
10/510679

DT05 Rec'd PCT/PTO 08 OCT 2004

specification, on pages 2-5, and their relevance is indicated therein.

Respectfully submitted,

By:


Mitchell W. Shapiro
Reg. No. 31,568

MWS:lmb

Miles & Stockbridge P.C.
1751 Pinnacle Drive, Suite 500
McLean, Virginia 22102-3833
(703) 903-9000

October 8, 2004

FORM PTO-14				Atty. Docket No. XA-10186 DT05 Rec'd PCT/PTO		Appln. No. 0 8 OCT 2004	
<u>LIST OF DOCUMENTS CITED BY APPLICANT</u>							
				Applicant MIYAKI, Yoshinori et al.			
				Filing Date Herewith		Group Art Unit	
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
	AA	2002/0041019	4/11/02	Gang		257	678
	AB	2002/0025607	2/28/02	Danno et al.		438	126
	AC	6,072,239	6/6/00	Yoneda et al.		257	730
	AD	4,790,897	12/13/88	Long		156	350
	AE						
	AF						
	AG						
FOREIGN PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
	AH	1 179 844	2/13/02	Europe			
	AI	2002-57241	2/22/02	Japan			no
	AJ	10-12773	1/16/98	Japan			no
	AK	2002-76040	3/15/02	Japan			no
	AL	0 773 584	5/14/97	Europe			
	AM	10-116935	5/6/98	Japan			no
	AN	2001-127199	5/11/01	Japan			no
	AO	0 289 102	11/2/88	Europe			
	AP	2-244646	9/28/90	Japan			no
	AQ	3-94459	4/19/91	Japan			no
	AR	11-354673	12/24/99	Japan			abstract
	AS	2000-77596	3/14/00	Japan			abstract
OTHER (including author, title, date, pertinent pages, etc.)							
	AU						
Examiner				Date Considered			
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							